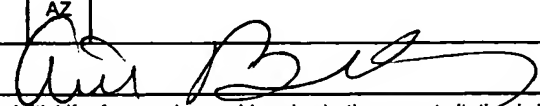


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 243326US2RD		SERIAL NO. 10/671,469	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takashi WAKUTSU, et al.			
				FILING DATE September 29, 2003		GROUP 2683	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
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	AK						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
As	AO	1 207 654 A2	05/22/2002	EUROPE			
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				Date Considered 1/24/2004			
*Examiner Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 243326US2RD		SERIAL NO. 10/671,469	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takashi WAKUTSU, et al.			
FILING DATE September 29, 2003				GROUP 2681			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
AB	AO	2000-165932	06/16/2000	JAPAN (with English Abstract)		X	
AB	AP	10-215121	08/11/1998	JAPAN (with English Abstract)		X	
AB	AQ	10-190514	07/21/1998	JAPAN (with English Abstract)		X	
AB	AR	9-284166	10/31/1997	JAPAN (with English Abstract)		X	
AB	AS	57-67335	04/23/1982	JAPAN (with English Abstract)		X	
AB	AT	6-284085	10/07/1994	JAPAN (with English Abstract)		X	
AB	AU	8-335904	12/17/1996	JAPAN (with English Abstract)		X	
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner 					<input type="checkbox"/> Additional References sheet(s) attached Date Considered 1/29/2002		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



SHEET 1 OF 1

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

243326US2RD

SERIAL NO.

10/671,469

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takashi WAKUTSU, et al.

FILING DATE

September 29, 2003

GROUP

2683

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AB	AA	5,966,667	10/12/1999	Stephanie S. HALLORAN, et al.	 	 	
	AB						
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	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
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AB	AO	195 26 730 A1	02/29/1996	Germany		x
AB	AP	0 971 551 A2	01/12/2000	Europe		
AB	AQ	WO 2004/001997 A1	12/31/2003	WIPO		
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AB	AW	Mehul MEHTA, et al., "Reconfigurable Terminals: An Overview of Architectural Solutions," IEEE COMMUNICATIONS MAGAZINE, IEEE SERVICE CENTER, XP002223682, August 2001, pages 82-89
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

And Behr

Date Considered

1/27/2004

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

243326US2RD

SERIAL NO.

10/671,469

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takashi WAKUTSU, et al.

FILING DATE

September 29, 2003

GROUP

2681

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
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A13	AO	4-242353	08/31/1992	JAPAN (with English Abstract)		X
A13	AP	2000-175264	06/23/2000	JAPAN (with English Abstract)		X
A13	AQ	11-18146	01/22/1999	JAPAN (with English Abstract)		X
	AR					
	AS					
	AT					
	AU					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered 1/24/2006

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LIST OF RELATED CASES

	<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/ Applicant</u>
AB	0039-7471-2	09/466,929	12/20/99	YOSHIDA et al.
AB	218429US2SRD	10/053,544	01/24/02	MUKAI et al.
AB	219295US2RD	10/080,538	02/25/02	WAKUTSU et al.
AB	243326US2RD*	10/671,469	09/29/03	WAKUTSU et al.

Am Bth

1/24/2006

*Present Application; listed for information

EHK/akh

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